

<b>Notice of References Cited</b>	Application/Control No. 10/722,723	Applicant(s)/Patent Under Reexamination KUZUYAMA ET AL.	
	Examiner Hai H. Huynh	Art Unit 3747	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,422,200 B1	07-2002	Morikawa et al.	123/305
	B	US-6,502,541 B2	01-2003	Abo et al.	123/295
	C	US-6,546,910 B2	04-2003	Tanaka et al.	123/348
	D	US-6,807,956 B2	10-2004	Gaessler et al.	123/568.14
	E	US-2003/0154964 A1	08-2003	Gaessler et al.	123/568.14
	F	US-2004/0261774 A1	12-2004	Eft, Neil Wallace	123/568.13
	G	US-2004/0244766 A1	12-2004	Fujieda et al.	123/299
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.